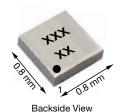
Vishay Siliconix

# N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
30	0.109 at V <sub>GS</sub> = 10 V	2.3					
	0.116 at V <sub>GS</sub> = 4.5 V	2.3	2.4 nC				
	0.123 at V <sub>GS</sub> = 3.7 V	2.2	2.4 110				
	0.142 at V <sub>GS</sub> = 2.5 V	2.0					

## MICRO FOOT® 0.8 x 0.8





Marking Code: xx = AH

xxx = Date/Lot traceability code

### **Ordering Information:**

Si8816EDB-T2-E1 (lead (Pb)-free and halogen-free)

#### **FEATURES**

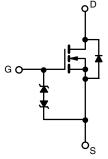
- TrenchFET® power MOSFET
- Ultra small 0.8 mm x 0.8 mm outline
- Ultra thin 0.4 mm max. height
- Typical ESD protection 1700 V (HBM)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- · Load switch
- OVP switch
- · High speed switching
- DC/DC converters
- For smart phones, tablet PCs, and mobile computing



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATING</b>	<b>S</b> (T <sub>A</sub> = 25 °C, u	nless otherv	wise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		V <sub>GS</sub>	± 12	V
	T <sub>A</sub> = 25 °C		2.3 <sup>a</sup>	
Continuous Drain Current /T 150 °C\	T <sub>A</sub> = 70 °C	1 ,	1.9 <sup>a</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	1.5 <sup>b</sup>	
	T <sub>A</sub> = 70 °C		1.2 <sup>b</sup>	А
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	8	
0 11 0 0 0 1	T <sub>A</sub> = 25 °C	,	0.7 <sup>a</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	0.4 b	
	T <sub>A</sub> = 25 °C		0.9 <sup>a</sup>	
Manian and Danier Dispiration	T <sub>A</sub> = 70 °C		0.6 <sup>a</sup>	14/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.5 b	W
	T <sub>A</sub> = 70 °C	1	0.3 b	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	00
Soldering Recommendations (Peak Temperature) c			260	°C

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient a, d	+ < 5.0	D	105	135	°C/W		
Maximum Junction-to-Ambient b, e	t ≤ 5 s	R <sub>thJA</sub>	200	260	]		

#### Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 5 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C/W.
- e. Maximum under steady state conditions is 330 °C/W.

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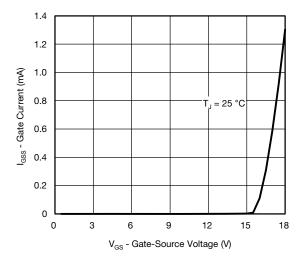
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	30	_	_	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 do 1 1, b = 1 p	-	30	_	mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	_	-3.2	_		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250  \mu A$	0.6	-	1.4	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 0.1	μΑ	
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	_	± 1		
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	-	_	1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	_	10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	10	-	-	Α	
	D(OII)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1 A	-	0.087	0.109		
		$V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$	-	0.093	0.116		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 3.7 \text{ V}, I_D = 1 \text{ A}$	-	0.096	0.123	Ω	
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 0.5 A	-	0.110	0.142		
Forward Transconductance a	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 A	-	10	-	S	
Dynamic <sup>b</sup>	313	50 - 75					
Input Capacitance	C <sub>iss</sub>			195	_		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	35		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	20 4 7 46 4 7	-	15			
·	Q <sub>g</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1 A	-	4.4	8	nC	
Total Gate Charge		50 1 7 00 1 7 5	-	2.4	4.5		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1 \text{ A}$	-	0.35	-		
Gate-Drain Charge	Q <sub>gd</sub>		-	0.55	-		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	-	4		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	15	30	- ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_L = 15 \Omega$	-	20	40		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A, } V_{GEN} = 4.5 \text{ V, } Rg = 1 \Omega$	-	20	40		
Fall Time	t <sub>f</sub>		-	10	20		
Turn-On Delay Time	t <sub>d(on)</sub>		-	5	10		
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_L = 15 \Omega$	-	10	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	15	30		
Fall Time	t <sub>f</sub>	_	_	5	10		
Drain-Source Body Diode Characteristic						_	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	_	_	0.7		
Pulse Diode Forward Current	I <sub>SM</sub>	-	-	-	8	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A, V <sub>GS</sub> = 0 V	-	0.75	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	3 . 33	-	16	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	6	12	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 1 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 ^{\circ}\text{C}$	-	13.5	-	1	
Reverse Recovery Rise Time t <sub>b</sub>			-	2.5	-	ns	

#### Note

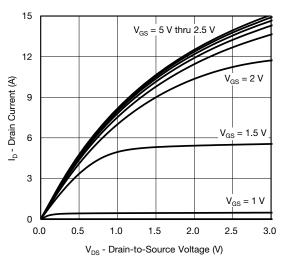
- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

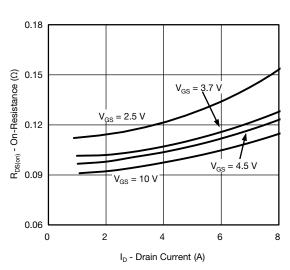




Gate Current vs. Gate-Source Voltage

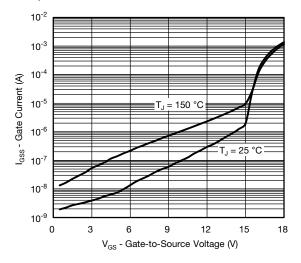


**Output Characteristics** 

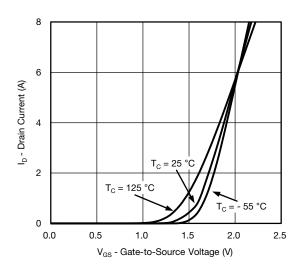


On-Resistance vs. Drain Current

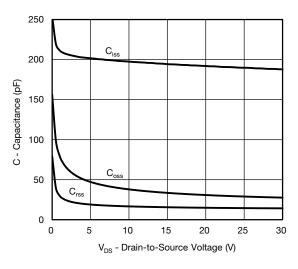
S15-0346-Rev. B, 23-Feb-15



Gate Current vs. Gate-Source Voltage

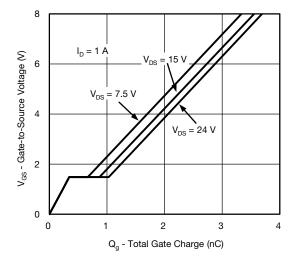


**Transfer Characteristics** 

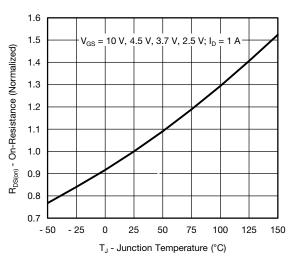


Capacitance vs. Drain-to-Source Voltage

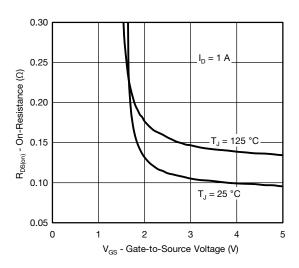




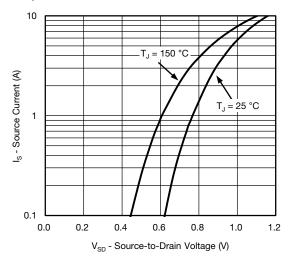
### **Gate Charge**



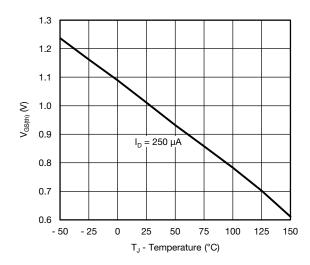
On-Resistance vs. Junction Temperature



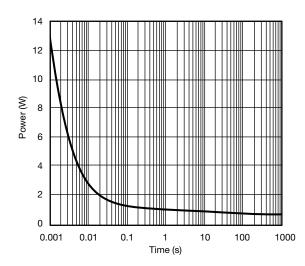
On-Resistance vs. Gate-to-Source Voltage



#### Source-Drain Diode Forward Voltage

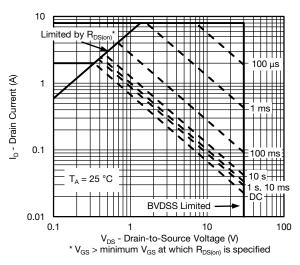


## **Threshold Voltage**

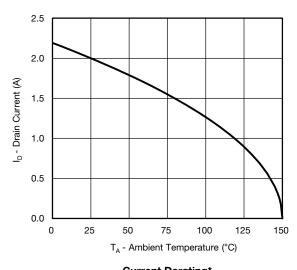


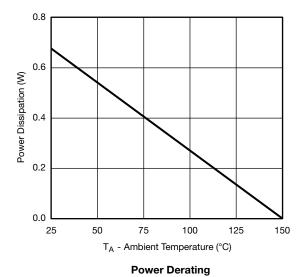
Single Pulse Power (Junction-to-Ambient)





Safe Operating Area, Junction-to-Ambient





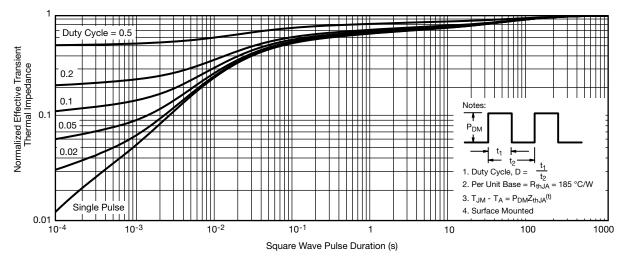
Current Derating\*

## Note

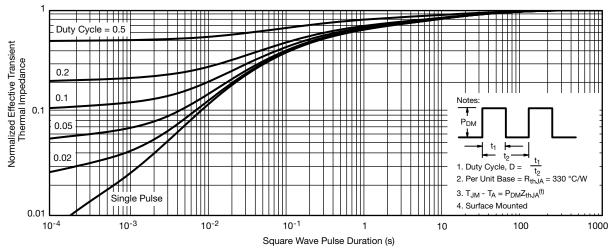
When mounted on 1" x 1" FR4 with full copper.

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_J$  (max.) = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Maximum Copper)

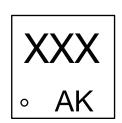


Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Minimum Copper)

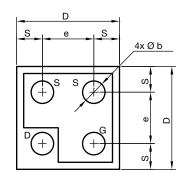
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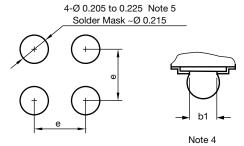
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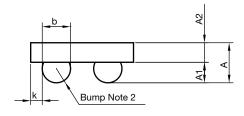
# MICRO FOOT®: 4-Bump (0.8 mm x 0.8 mm, 0.4 mm Pitch)



Mark on Backside of die







### Notes

- (1) Laser mark on the backside surface of die
- (2) Bumps are 95.5 % Sn,3.8 % Ag,0.7 % Cu
- (3) "i" is the location of pin 1
- (4) "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- (5) Non-solder mask defined copper landing pad.

DIM.	MILLIMETERS a			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
Α	0.328	0.365	0.402	0.0129	0.0144	0.0158
A1	0.136	0.160	0.184	0.0053	0.0062	0.0072
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086
b	0.200	0.220	0.240	0.0078	0.0086	0.0094
b1	0.175			0.0068		
е	0.400			0.0157		
S	0.160	0.180	0.200	0.0062	0.0070	0.0078
D	0.720	0.760	0.800	0.0283	0.0299	0.0314
K	0.040	0.070	0.100	0.0015	0.0027	0.0039

#### Note

a. Use millimeters as the primary measurement.

ECN: T15-0053-Rev. A, 16-Feb-15

DWG: 6033

Revision: 16-Feb-15 1 Document Number: 69442



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Revision: 13-Jun-16 1 Document Number: 91000

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